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APPLICATION NO. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
09/955,632 09/18/2001			Kunal R. Parekh	MI22-1816	3955	
21567	7590 0	01/29/2004		EXAMINER		
WELLS ST.		HUYNH, YENNHU B				
SPOKANE,	T AVENUE, SU WA 99201	JIIE 1300		ART UNIT	PAPER NUMBER	
,				2813		

DATE MAILED: 01/29/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.		Applicant(s)						
Office Action Summary			09/955,632		PAREKH ET AL.					
			Examiner		Art Unit					
			Yennhu B Hu	<u> </u>	2813					
	The MAILING DATE of this communication app ars on the cov r sheet with the correspondence address Period for Reply									
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status										
	Responsive to communication(s) filed	d on <i>31 O</i> d	ctober 2003.							
	This action is FINAL . 2b) ☐ This action is non-final.									
,	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.									
Disposition of Claims										
4)⊠	Claim(s) 1-25 and 44-59 is/are pending in the application.									
-	4a) Of the above claim(s) is/are withdrawn from consideration.									
6)⊠ 7)□	Claim(s) <u>5-25 & 44-59</u> is/are allowed. Claim(s) <u>1-4</u> is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/or election requirement.									
Applicati	ion Papers									
9)☐ The specification is objected to by the Examiner.										
10)	The drawing(s) filed on is/are:	a)☐ acce	epted or b)	objected to by the E	xaminer.					
	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).									
	Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).									
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.										
Priority under 35 U.S.C. §§ 119 and 120 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 13) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application) since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78. a) The translation of the foreign language provisional application has been received. 14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121 since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78.										
Attachment(s)										
2) Notic	te of References Cited (PTO-892) te of Draftsperson's Patent Drawing Review (PT mation Disclosure Statement(s) (PTO-1449) Pa		5)	Interview Summary (Notice of Informal Pa Other:						

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DETAILED ACTION

This Office Action is in response to the Amendment filed on 10/31/03.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-4 are rejected under 35 U.S.C. 102(b, e) as anticipated by or, in the alternative, under 35 U.S.C. 103(a) as obvious over Figura et al. (U.S. 5,963,804).

Figura et al. at figs. 1-6 in col. 1-18 disclose a method of making a doped silicon structure, which include:

-Re. Claims1, 2: forming a solid mass of silicon material within an opening 18 formed over a doped region 12a of a silicon substrate 12, the mass comprising only two forms of silicon, a undoped silicon layer 20 in physical contact with doped silicon (col.6, lines 41-43); forming rugged polysilicon 20b from one of the forms of silicon or from the exposed undoped silicon 20b, and not from another of the form of silicon (col.6, lines 9-46), and forming a cell plate proximate the rugged polysilicon (fig.7, col. 11, lines 1-7); wherein the undoped silicon 20 in contact with the doped diffusion region 11 through plug 12 (fig. 2).

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-Re. claims 3 & 4: wherein the doped silicon comprises a dopant concentration of at least 5x10 18atoms/cm2 or undoped silicon comprises a dopant concentration of at 1x10 19atoms/cm2.

The range of dopant concentration is considered to involve routine optimization while has been held to be within the level of ordinary skill in the art, As noted In re Aller 105 USPQ233, 255 (CCPA 1955). the selection of reaction parameters such as temperature and concentration would have been obvious.

"Normally, it is to expected that a change in temperature, or in range, concentration, cycles, thickness, would be an unpatentable modification. Under some circumstance, however, changes such as these may be impart patentability to a process if the particular ranges claimed produce a new and unexpected result which is different in kind and not merely degree from the results of the prior art ... such ranges are termed "critical ranges and the applicant has the burden of proving such criticality ... More particularly, where the general conditions of a claim are disclosed in the prior art, it is not inventive to discover the optimum or workable ranges by routine experimentation." In re Aller 105 USPQ233, 255 (CCPA 1955). See also In re Waite 77 USPQ 586 (CCPA 1948); In re Scherl 70 USPQ 204 (CCPA 1946); In re Irmscher 66 USPQ 314 (CCPA 1945); In re Norman 66 USPQ 308 USPQ 308 (CCPA 1945); In re Swenson 56 USPQ 372 (CPA 1942); In re Sola 25 USPQ 433 (CCPA 1935); In re Dreyfus 24 USPQ 52 (CCPA 1934).

Response to Arguments

Applicant's arguments filed 7/3/03 have been fully considered but they are not persuasive.

Applicant argues that Figura teaches the polysilicon layers 20 and 20b are not in physical contact with a doped region.

Figura teaches the layer 20a is just the surface of the polysilicon layer 20 that comprises light doped silicon, and the result is a roughened texture of 20b after annealing. Therefore, the polysilicon layers 20 or 20b are formed in physical contact with a doped region (col.6, lines 32-46, fig.2).

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Therefore, **THIS ACTION IS MADE FINAL to claims 1-4.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Allowable Subject Matter

Claims 5-25 & 44-59 are allowable over prior art of record.

The following is an examiner's statement of reasons for allowance: Prior art of record do not disclose a method of forming capacitors, which include exposing the two forms of silicon to common subsequent processing conditions which substantially selectively form rugged polysilicon from one of the exposed two forms of silicon and not from another of the exposed two forms of silicon (cl. 11); wherein the mass comprising a solid core of doped silicon substantially surrounded by undoped silicon leaving expose doped silicon and exposed undoped silicon, and the mass further comprising a portion of the undoped silicon in contact with the doped diffusion region (cls.5); wherein forming HSG from the undoped silicon of the exposed outer sidewall surface, the exposed outer

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sidewall surface comprising an only portion of the storage node which comprises HSG (cl. 13); forming a second undoped silicon layer within the further narrowed opening in defining capacitor storage node, and removing a portion of the insulative layer to expose a sidewall surface of the storage node comprising the first undoped silicon layer (cl.24).

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Yennhu B Huynh whose telephone number is 703-308-6110 (and the new telephone number 571-272-1692 will be effected from 2/5/04). The examiner can normally be reached on 8.30AM-7.00PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl Whitehead, Jr., can be reached on 703-308-4940. The fax phone numbers for the organization where this application or proceeding is assigned are 703-308-7722 for regular communications and 703-308-7722 for After Final communications.

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Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-7724.

YNBH, Examinar Jahr. 1/21/04